

**Search Notes**

Application/Control No.

10/830,008

Examiner

Khiem Nguyen

Applicant(s)/Patent under  
Reexamination

TAKAHASHI, KEI

Art Unit

2839

**SEARCHED**

Class	Subclass	Date	Examiner
439	327	6/5/2005	KN
↓	347	↓	↓
↓	638	↓	↓
↓	945	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR